

**Search Notes**

Application/Control No.

10/606,644

Examiner

Jezia Riley

Applicant(s)/Patent under  
Reexamination

REED ET AL.

Art Unit

1637

**SEARCHED**

Class	Subclass	Date	Examiner
536	23.1 25.3 25.33 25.34 26.22		
435	6	7/7/2005	JR

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STN search enclosed	7/7/2005	JR